

N-Channel Silicon Carbide MOSFET Module

Rev.02 - 01 March 2025

**Product data sheet** 

alogen-Free

ead-Free

### **1. General description**

WeEnPACK-B1 module with WeEn 1200V Gen2 SiC MOSFET and Press-fit pin type. NTC temperature sensor inside.

### 2. Features and benefits

- 3-phase full bridge topology
- Press-fit pin configuration
- Low ON resistance
- Low switching losses
- Reduced Q<sub>g</sub> and C<sub>rss</sub>
- Minimized circuit impedance
- Robust product design

### 3. Applications

- EV chargers
- Energy storage and solar energy systems
- Power Inverters
- AC/DC converters
- Power factor correctors
- Motor drives

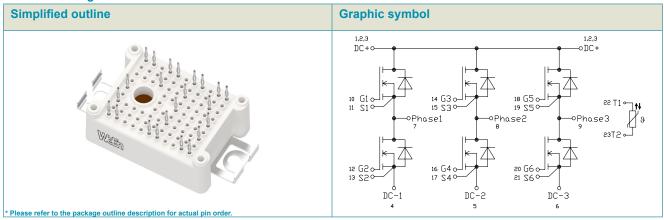
### 4. Quick reference data

able 1. Q	uick reference data						
Symbol	Parameter	Conditions	Notes	Values		i	Unit
Absolute	maximum rating						
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C			1200		V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>h</sub> = 25 °C			28		А
P <sub>tot</sub>	total power dissipation	T <sub>h</sub> = 25 °C			63		W
T <sub>j.op</sub>	maximum junction temperature			-40 to 150		°C	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics				·		
$R_{\text{DS(on)}}$	drain-source on-state resistance	V <sub>GS</sub> = 15 V; I <sub>D</sub> = 50 A; T <sub>j</sub> = 25 °C		-	60	-	mΩ
		$V_{GS}$ = 18 V; I <sub>D</sub> = 50 A; T <sub>j</sub> = 25 °C		-	48	68	mΩ
Dynamic	characteristics			1			
Q <sub>G(tot)</sub>		$I_{D} = 25 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	83	-	nC
$Q_{GD}$	gate-drain charge	T <sub>j</sub> = 25 °C		-	15	-	nC
Source-d	rain diode						
Q <sub>r</sub>	recovered charge	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$		-	428	-	nC

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# 5. Pinning information





# 6. Ordering information

Table 3. Ordering information									
Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date			
WMSC060S12B1P	WeEnPACK-B1	WMSC060S12B1P6T	Tray		WeEnPACK- B1PSB-B	13-Jun-2024			

# 7. Marking

Table 4. Marking codes								
Type number	Marking codes							
WMSC060S12B1P	WMSC060S12B1P							

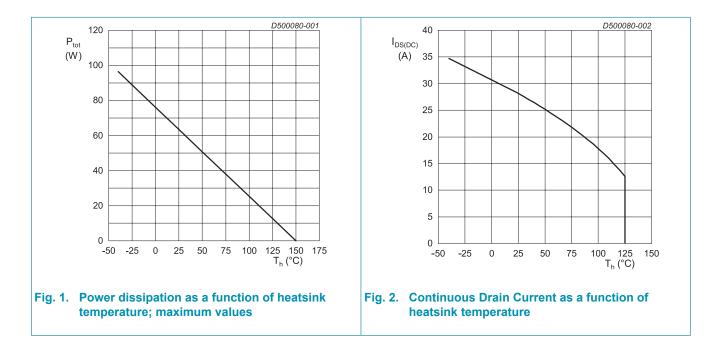
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# 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
T <sub>stg</sub>	storage temperature			-40 to 125	°C
T <sub>j.op</sub>	operating junction temperature			-40 to 150	°C
T <sub>j.max</sub>	maximum junction temperature	Intermittent condition with shortened lifetime		-40 to 175	°C
V <sub>ISOL</sub>	RMS isolation voltage	T <sub>j</sub> = 25 °C; all terminals shorted; f = 50 Hz; t = 1 s		3500	V
MOSFET					
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C		1200	V
V <sub>GS,max</sub>	gate-source voltage	Absolute maximum values		-12 to 24	V
$V_{GS,op}$	gate-source voltage	Recommended operational values		-4 to 18	V
P <sub>tot</sub>	total power dissipation	T <sub>h</sub> = 25 °C		63	W
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>h</sub> = 25 °C		28	А
		V <sub>GS</sub> = 18 V; T <sub>h</sub> = 100 °C		18	А
I <sub>DM</sub>	peak drain current	pulse width $t_p$ limited by $T_{jmax}$		56	А
E <sub>as</sub>	single pulse drain-to- source avalanche	$I_{AS}$ = 15 A; L = 1 mH; V <sub>DD</sub> = 100 V; $T_{j(init)}$ = 25 °C; per MOSFET		113	mJ
Body Dioc	le	·	I		
I <sub>SD</sub>	DC body diode forward current	V <sub>GS</sub> = -4 V; T <sub>h</sub> = 25 °C		14	А
I <sub>SD,pulse</sub>	Pulse body diode current	verified by design, $t_p$ limited by $T_{jmax}$		56	А

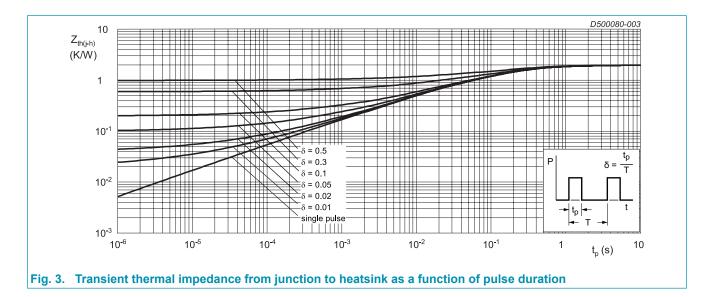


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### 9. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	per MOSFET		-	0.9	-	K/W
$R_{th(j-h)}$	thermal resistance from junction to heatsink	per MOSFET, $\lambda_{grease} = 1$ W/(m·K), thick <sub>grease</sub> = 50 um		-	1.97	-	K/W
Internal l	solation	basic insulation (class 1, IEC 61140)		Al <sub>2</sub> O <sub>3</sub>			
d <sub>Creep</sub>	Creepage distance	terminal to heatsink		-	11.5	-	mm
		terminal to terminal		-	6.3	-	mm
d <sub>Clear</sub>	Clearance	terminal to heatsink		-	10	-	mm
		terminal to terminal		-	5	-	mm
СТІ	Comperative tracking index				>200	_	
F	Mounting force per clamp			20	-	50	N
G	Approximate Weight			-	20	-	g

Note: Module is ESD sensitive. Handling precautions are recommended.



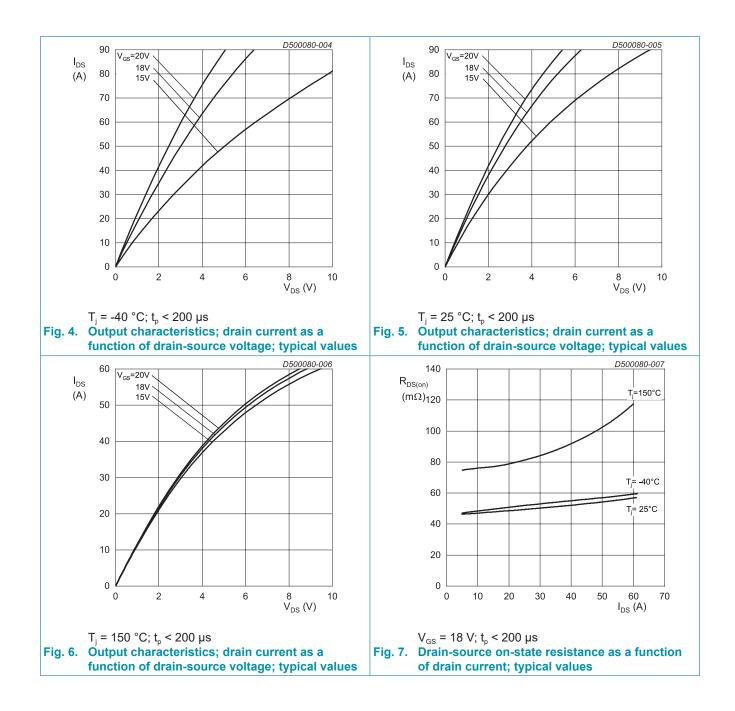
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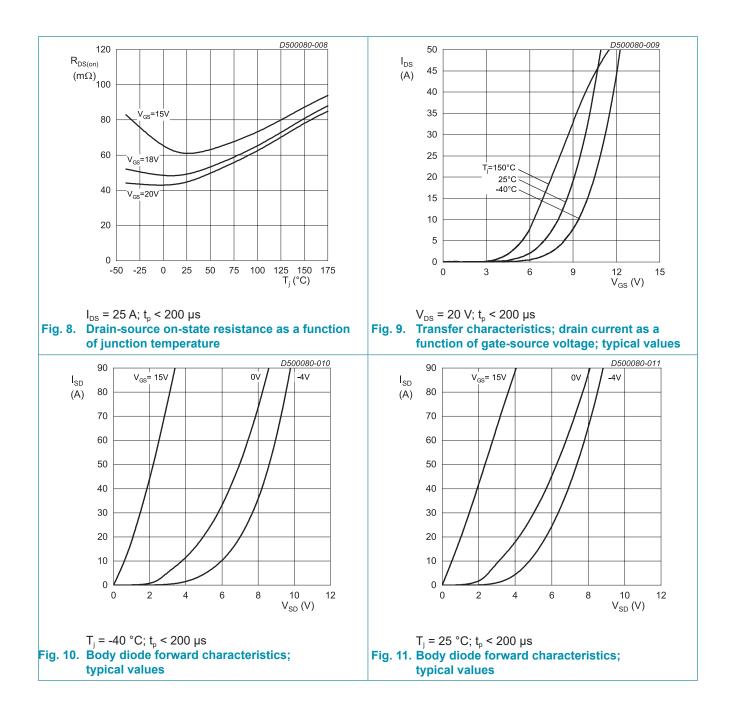
# **10. Characteristics**

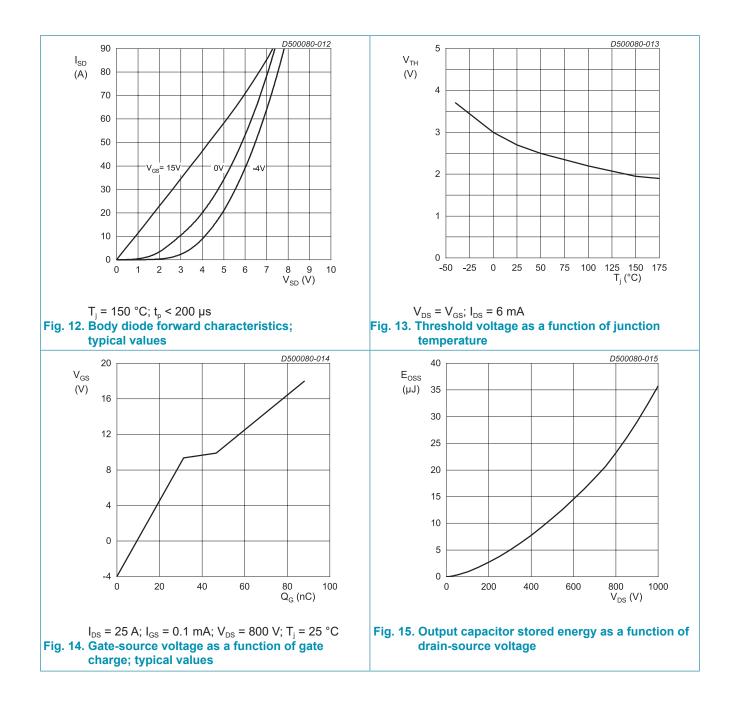
### Table 7. Characteristics

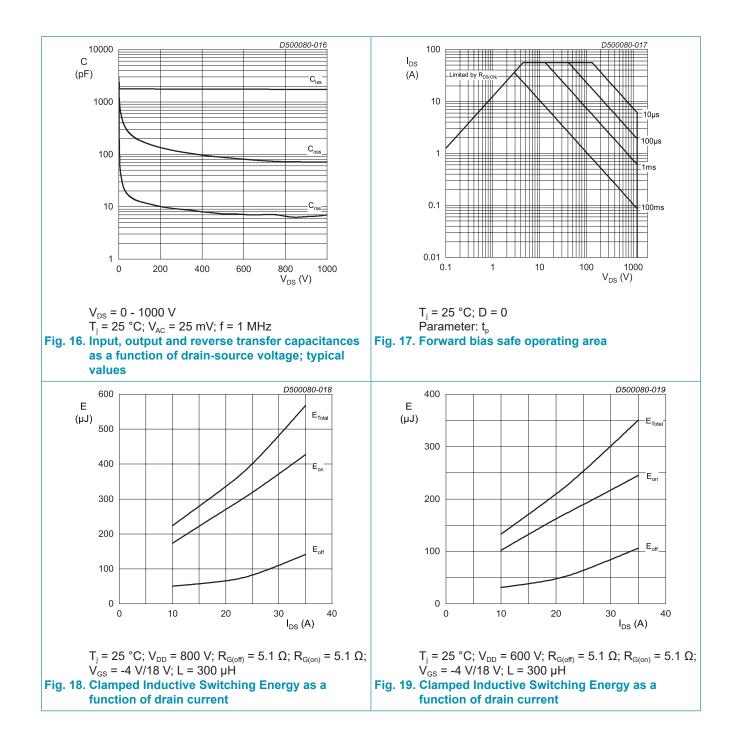
MOSFET							
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_{D}$ = 100 µA; $V_{GS}$ = 0 V; $T_{j}$ = 25 °C		1200	-	-	V
$V_{\text{GS(th)}}$	gate-source threshold	$I_{D} = 6 \text{ mA}; V_{DS} = V_{GS}; T_{j} = 25 \text{ °C}$		1.9	2.5	3.5	V
	voltage	I <sub>D</sub> = 6 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C		-	1.9	-	V
I <sub>DSS</sub>	drain leakage current	$V_{DS}$ = 1200 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C		-	0.2	100	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = 24 V; $V_{DS}$ = 0 V; $T_{j}$ = 25 °C		-	10	100	nA
	(absolute value)	$V_{GS}$ = -12 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C		-	10	100	nA
$R_{\text{DS(on)}}$	drain-source on-state	$V_{GS}$ = 15 V; $I_{D}$ = 25 A; $T_{j}$ = 25 °C		-	60	-	mΩ
	resistance	$V_{GS}$ = 18 V; $I_{D}$ = 25 A; $T_{j}$ = 25 °C		-	48	68	mΩ
		$V_{GS}$ = 18 V; $I_{D}$ = 25 A; $T_{j}$ = 125 °C		-	70	-	mΩ
		V <sub>GS</sub> = 18 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 150 °C		-	81	-	mΩ
		V <sub>GS</sub> = 18 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 175 °C		-	85.1	-	mΩ
R <sub>G</sub>	gate resistance	f = 1 MHz; $T_j$ = 25 °C; per MOSFET		-	2.2	-	Ω
g <sub>fs</sub>	transconductance	$V_{DS}$ = 20 V; $I_{D}$ = 25 A; $T_{j}$ = 25 °C		-	14	-	S
Dynamic	characteristics						
Q <sub>G(tot)</sub>	total gate charge	$I_{\rm D} = 25 \text{ A}; V_{\rm DS} = 800 \text{ V}; V_{\rm GS} = -4 \text{ V}/18 \text{ V};$		-	83	-	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C		-	31	-	nC
$Q_{GD}$	gate-drain charge			-	15	-	nC
C <sub>iss</sub>	input capacitance	$V_{DS} = 1000 V; V_{GS} = 0 V; f = 1 MHz;$		-	1731	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C		-	71	-	pF
C <sub>rss</sub>	reverse transfer capacitance			-	7	-	pF
E <sub>oss</sub>	Coss stored energy			-	36	-	μJ
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	18	-	ns
t <sub>r</sub>	rise time	R <sub>G(off)</sub> = 5.1 Ω; R <sub>G(on)</sub> = 5.1 Ω; I <sub>D</sub> = 25 A; L = 300 μH; T <sub>i</sub> = 25 °C		-	8	-	ns
t <sub>d(off)</sub>	turn-off delay time			-	37	-	ns
t <sub>f</sub>	fall time			-	14	-	ns
Eon	turn-on energy			-	317	-	μJ
E <sub>off</sub>	turn-off energy	1		-	78	-	μJ

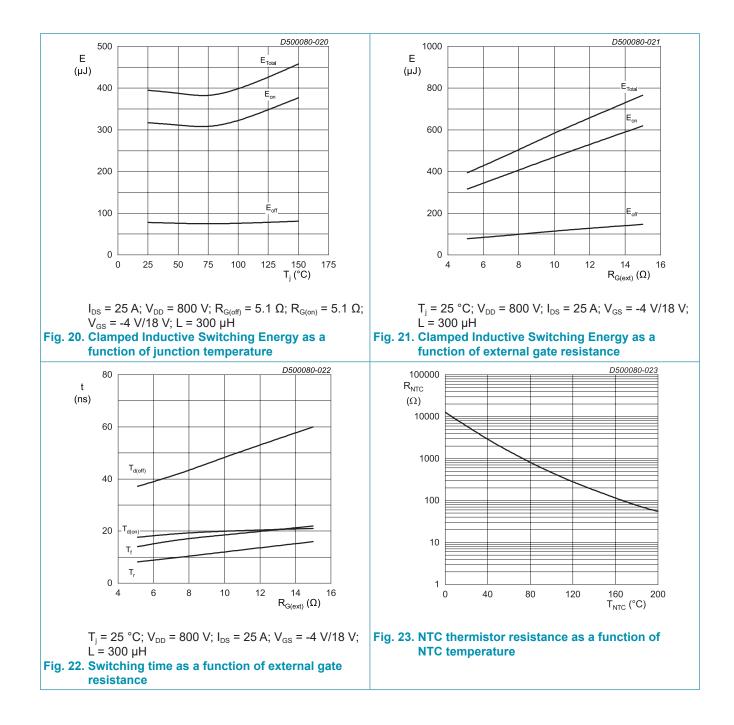
Body dio		0	N. C.		-		11.14
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
$V_{\text{SD}}$	source-drain voltage	$V_{GS}$ = -4 V; $I_{SD}$ = 25 A; $T_j$ = 25 °C		-	5.5	-	V
		$V_{GS}$ = -4 V; $I_{SD}$ = 25 A; $T_j$ = 150 °C		-	5.0	-	V
Dynamic	characteristics						
l <sub>rrm</sub>	reverse recovery current	$I_{SD}$ = 25 A; $V_{GS}$ = -4 V/18 V; $V_{R}$ = 600 V;		-	37	-	А
t <sub>rr</sub>	reverse recovery time	di/dt = 2800 A/μs; R <sub>G(ext)</sub> = 5.1 Ω; T <sub>i</sub> = 25 °C		-	20	-	ns
Q <sub>r</sub>	recovered charge	]		-	428	-	nC
E <sub>rec</sub>	reverse recovery energy			-	25	-	μJ
I <sub>rrm</sub>	reverse recovery current	$I_{SD} = 25 \text{ A}; V_{GS} = -4 \text{ V}/18 \text{ V}; V_{R} = 600 \text{ V};$		-	58	-	А
t <sub>rr</sub>	reverse recovery time	di/dt = 3200 A/μs; R <sub>G(ext)</sub> = 5.1 Ω; T <sub>i</sub> = 150 °C		-	24	-	ns
Q <sub>r</sub>	recovered charge	J		-	876	-	nC
E <sub>rec</sub>	reverse recovery energy			-	116	-	μJ
NTC ther	mistor						,
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R <sub>25</sub>	Rated resistance	T <sub>NTC</sub> = 25 °C		-	5000	-	Ω
R <sub>100</sub>		T <sub>NTC</sub> = 100 °C		493±5%		Ω	
B <sub>25/50</sub>	B-value	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298.15K))]$		3380			К
	Maximum operating temperature			-	200	-	°C
	Dissipation costant			-	2	-	mW/K
	Thermal time constant			-	≤10	-	s





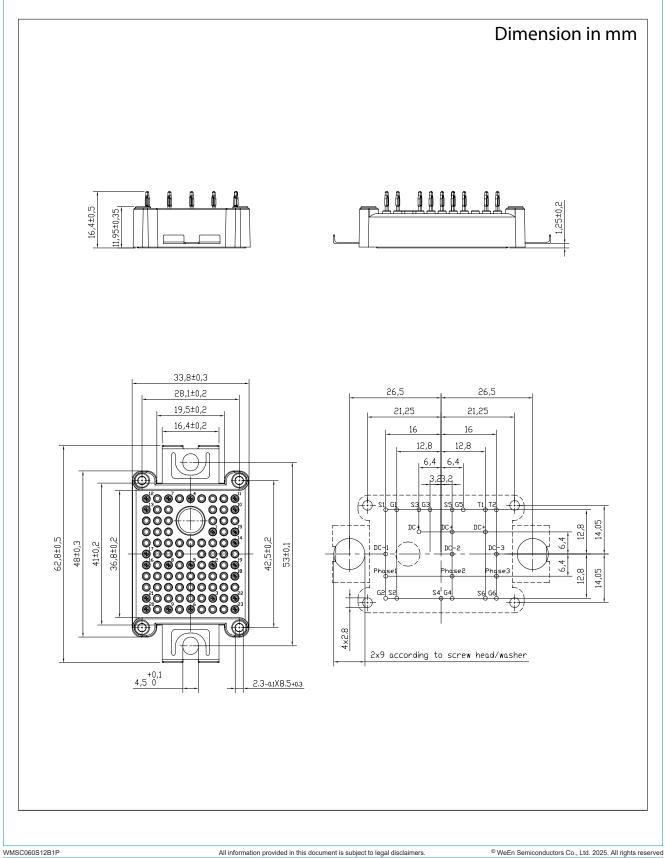






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### 11. Package outline



#### **N-Channel Silicon Carbide MOSFET Module**

# 12. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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